U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. MICRON.098DV2	APPLICATION NO. 10/614,418
BY APPLICANT	APPLICANT Basceri, et al.	
(USE BEVERAL SHEETS IF NECESSARY)	FILING DATE July 3, 2003	GROUP 2831

U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	, NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)		
NH	1	5,581,436	12/03/96	Summerfelt et al.	361	321.1			
1111	2	6,285,051	09/04/01	Ueda et al.	257	296			

			FOREIGN PATENT DOCUMENTS				
EXAMINER	. DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSI	ATION
INITIAL						YES .	NO
NH 3	WO 95/25340	09/21/95	EP				

EXAMINER INITIAL		OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
NX	4	Joo, "Fabrication and Characterization of MOCVD (Ba, Sr)TiO3 Thin Films for High Density Capacitors", Proceeding of 1997 5th International Conference an VLSI and CAD", The Secretariat of ICVC '97, 1997.

O:\DOCS\LJM\LJM-3813.DOC:cbm 050704

EXAMINER

DATE CONSIDERED

*EXAMINER: INITIAL'S CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609 DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.

	M PTC	PATENT AND T	TRADEMARK OF		APPLIC/ 10/614	ATION NO. 1418			
BY APPLICANT			APPLICANT Basceri et al.						
. 0		SEVERAL SHEETS IF NECES	3SARY)	FILING DATE July 3, 2003	GROUP Unkno		1	•	
AT & TRADER				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING		
49	1.	6,238,966	05/29/01	Ueda et al.			/# Ci i i		
	-								
					`				
							·		
FOREIGN PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO		
HIIIAC							YES		
	\Box								
			(2)					-	
EXAMINER INITIAL		O1	THER DOCUME	NTS (INCLUDING AUTHOR, TITLE, DATE, PE	ERTINENT PAGES, E	ETC.)	 -		
	+				···				
					 				
J-IDOCSII II	WLJW	1-2909.DOC							
01003		/ , \ /	۸	_	,	2			